Se	arch	ch Notes		

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/614,053	YAJNIK ET AL.	
Examiner .	Art Unit	
Sai-Ming Chan	2609	

SEARCHED			
Class	Subclass	Date	Examiner
370	351	2/20/2007	sc
709	217	2/20/2007	sc
711	113	2/21/2007	sc
711	118	2/21/2007	sc
711	137	2/22/2007	sc
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
·	: DATE	EXMR	
EAST Image and keyword search in USPAT, US-PGPUB, DERWENT, EPO, JPO, and IBM_TDB (see attached search strategy)	2/22/2007	SC	
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